

Search Notes

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Examiner

Hai Tran

Applicant(s)/Patent under
Reexamination

NISHINA ET AL.

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
715	513,516, 517,522, 526	5/12/2006	HVT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST updated search	5/12/2006	HVT